

Search Notes

Application/Control No.

09/841,598

Examiner

Sargon N. Nano

Applicant(s)/Patent under
Reexamination

MATSUDA, KOUICHI

Art Unit

2157

SEARCHED

Class	Subclass	Date	Examiner
709	203-204 206 223-224 227-228	5/3/2005	SN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
709	204 206	5/3/2005	SN
709	224 227	5/3/2005	SN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search (see attached search report)	5/3/2005	SN
Consulted with primary Examiner Saleh Najjar A.U. 2157	5/3/2005	SN
Npl Search (google search, IEEE search)	5/3/2005	SN